



ALPHA & OMEGA
SEMICONDUCTOR

AOC2802

Common-Drain Dual N-Channel Enhancement Mode Field Effect Transistor

General Description

The AOC2802 uses advanced trench technology to provide excellent $R_{SS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V while retaining a 12V $V_{GS(MAX)}$ rating. It is ESD protected. This device is suitable for use as a uni-directional or bi-directional load switch, facilitated by its common-drain configuration.

Product Summary

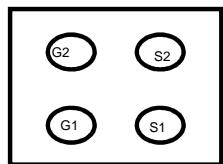
V_{SS}	20V
I_D (at $V_{GS}=4.5V$)	6A
$R_{SS(ON)}$ (at $V_{GS}=4.5V$)	< 34mΩ
$R_{SS(ON)}$ (at $V_{GS}=4.0V$)	< 35mΩ
$R_{SS(ON)}$ (at $V_{GS}=3.1V$)	< 43mΩ
$R_{SS(ON)}$ (at $V_{GS}=2.5V$)	< 54mΩ



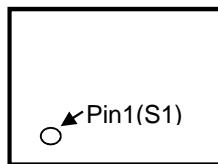
WLCSP 1.57x1.57_4



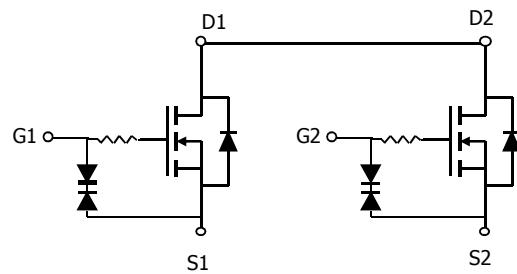
Bottom View



Top View



Equivalent Circuit



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Source-Source Voltage	V_{SS}	20	V
Gate-Source Voltage	V_{GS}	± 12	V
Source Current (DC) ^{Note1}	I_S	6	A
Source Current (Pulse) ^{Note2}	I_{SM}	60	
Power Dissipation ^{Note1}	P_D	1.3	W
Junction and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C

Note 1. Mounted on minimum pad PCB

Note 2. PW <300 μs pulses, duty cycle 0.5% max

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{SSS}	Source-Source Breakdown Voltage	$I_S=250\mu\text{A}, V_{GS}=0\text{V}$, Test Circuit 6	20			V
I_{SSS}	Zero Gate Voltage Source Current	$V_{SS}=20\text{V}, V_{GS}=0\text{V}$, Test Circuit 1 $T_J=55^\circ\text{C}$		1	5	μA
I_{GSS}	Gate leakage current	$V_{SS}=0\text{V}, V_{GS}=\pm 10\text{V}$, Test Circuit 2		1	10	
BV_{GSO}	Gate-Source Breakdown Voltage	$V_{SS}=0\text{V}, I_G=\pm 250\mu\text{A}$, Test Circuit 7	± 12			V
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{SS}=V_{GS}, I_S=250\mu\text{A}$, Test Circuit 3	0.5	1	1.5	V
$R_{\text{SS(ON)}}$ Note	Static Source to Source On-Resistance	$V_{GS}=4.5\text{V}, I_S=3\text{A}$, Test Circuit 4 $T_J=125^\circ\text{C}$		28	34	$\text{m}\Omega$
		$V_{GS}=4.0\text{V}, I_S=3\text{A}$, Test Circuit 4		41	48	
		$V_{GS}=3.1\text{V}, I_S=3\text{A}$, Test Circuit 4		30	35	
		$V_{GS}=2.5\text{V}, I_S=3\text{A}$, Test Circuit 4		36	43	
				45	54	
g_{FS}	Forward Transconductance Note	$V_{SS}=5\text{V}, I_S=3\text{A}$, Test Circuit 3		19		S
V_{FSS}	Diode Forward Voltage Note	$I_S=1\text{A}, V_{GS}=0\text{V}$, Test Circuit 5		0.6	1	V
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{SS}=10\text{V}, f=1\text{MHz}$,		1000	1200	pF
C_{oss}	Output Capacitance			152		pF
C_{rss}	Reverse Transfer Capacitance			114		pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{SS}=0\text{V}, f=1\text{MHz}$		1.5		$\text{k}\Omega$
SWITCHING PARAMETERS						
$t_{D(\text{on})}$	Turn-On DelayTime	$V_{GS}=10\text{V}, V_{SS}=10\text{V}, R_L=1.5\Omega, R_{\text{GEN}}=6\Omega$,		284		ns
t_r	Turn-On Rise Time			900		ns
$t_{D(\text{off})}$	Turn-Off DelayTime			5		μs
t_f	Turn-Off Fall Time			4.8		μs
Q_g	Total Gate Charge	$V_{G1S1}=4.5\text{V}, V_{SS}=10\text{V}, I_S=6\text{A}$		10.4		nC

Note: Pulsed

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

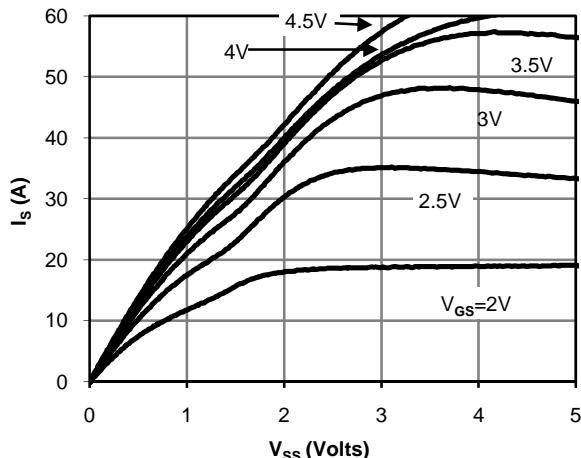


Fig 1: On-Region Characteristics

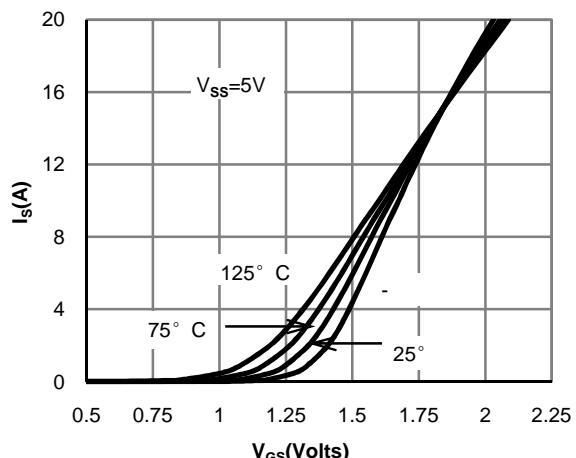


Figure 2: Transfer Characteristics

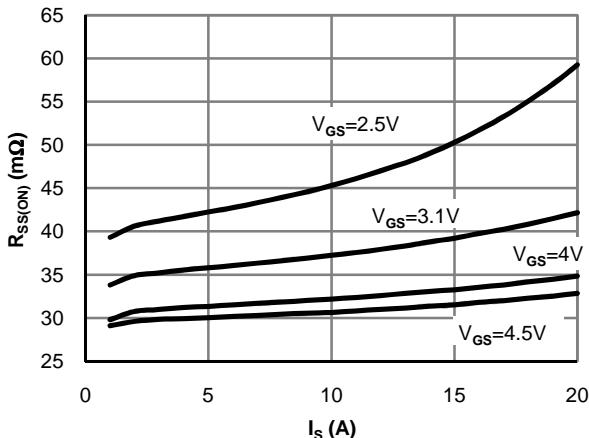


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

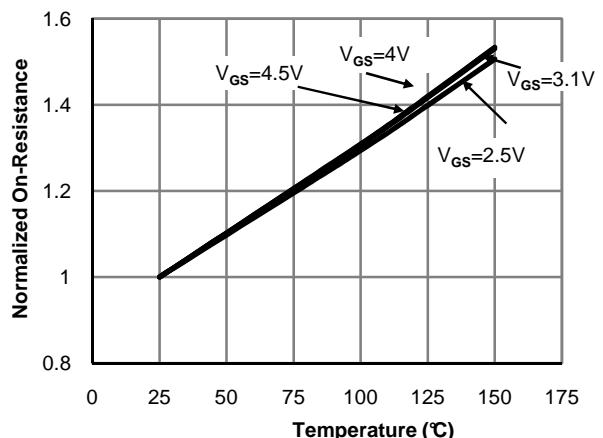


Figure 4: On-Resistance vs. Junction Temperature

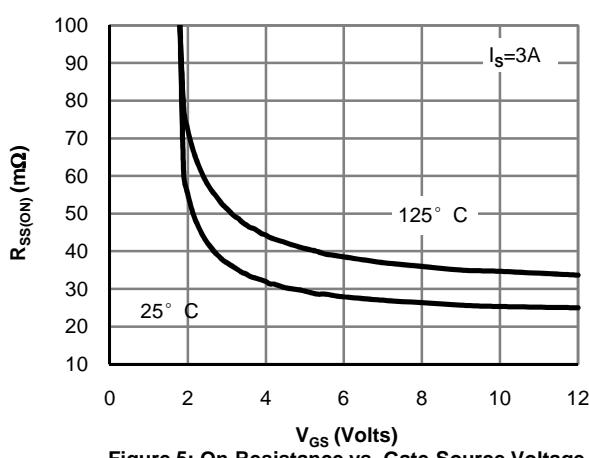


Figure 5: On-Resistance vs. Gate-Source Voltage

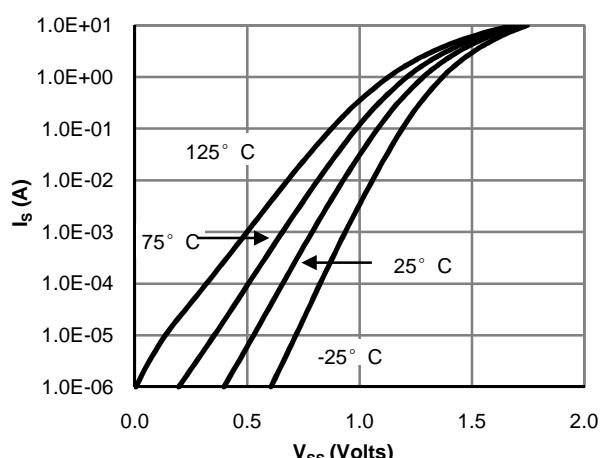


Figure 6: Body-Diode Characteristics

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